



Fig. 2. Measurement method employed. The small differential voltage is represented by the hatched area inside the first sampling window of length T_i .

shown in Fig.1). The sampling frequency f_s is adjusted according to the same procedure as described in [1], which asks for a target phase of exactly $\pi/4$, wherein the sampling window is centered.

The alternating signal $v_{AC}(t)$ is sampled with four or more samples per period equally spaced in time over many periods. The phase ϕ_{AC} of $v_{AC}(t)$ is computed by fast-Fourier transform. The deviation of phase from the target phase of exactly ($\pi/4$) is fed to a digital proportional integrating regulator, whose output is a new sampling frequency $f_s(1+\xi_s)$ (maintained over a time span Δt and thereafter set to its original value f_s to cause precise phase increments as in [1]). The fractional dimensionless change ξ_s of frequency f_s is calculated according to

$$\xi_s = \frac{\phi_{AC} - \pi/4}{2\pi f_s \Delta t}. \quad (1)$$

Fig. 2 shows illustratively this process after approaching the target phase ($\pi/4$) by a negligible threshold (defined by the user). Afterwards, differential voltages to compute the rms of $v_{AC}(t)$ are sampled according to the relation in the insert of Fig. 2. The differential voltages at each sampling point n , i.e., $y(nT_s)$ tend to zero when the peak value of $v_{AC}(t)$, i.e., V_{ACm} satisfies the following relation (due to the frequency response of the integrating digitizer):

$$V_{ACm} = \frac{V_{DC} \cdot \sqrt{2}}{\text{sinc}(\pi f_0 T_i)}, \quad (2)$$

where the sinc function stands for the sine cardinalis ($\text{sinc}(x) = \sin(x)/x$), f_0 for the fundamental frequency in hertz of $v_{AC}(t)$ and T_i for the aperture time (in seconds) of the DVM. The smaller the differential voltages are, the smaller is the effect of inaccuracies of the digitizer in the determination of the rms value of $v_{AC}(t)$. The ‘Sign’ function is realized by the commutating switch and is 1 when $v_{AC}(t) \geq 0$ and -1 when $v_{AC}(t) < 0$. This function is

generated by a zero-synch output of the in house made synchronizer.

IV. MEASUREMENT RESULTS

First investigations were done with filtered sources with expected spurious harmonic distortions below -120 dBc. Measurement repeatability is excellent ranging from 1×10^{-7} to 1×10^{-6} , dominated by noise of the sampler and sources. Although any integration time can be chosen, charging up of the internal filters of the DVM is responsible for a considerable spread of values. At present, investigations are being done to evaluate the metrological feasibility of the method including measurement uncertainties. A piece of hardware is under construction to avoid saturation of the DVM input-circuitry when lower ranges (as the 100 mV range) shall be employed to measure differential voltages. More information will be presented at the conference.

VI. CONCLUSION

An efficient method for calibrating ‘spectrally pure’ sine waveforms was presented. In this case, a Zener reference can substitute an expensive PJVS. The setup can also represent a secondary standard, and the low sampling rate allows extension of frequency up to the audio range. Very accurate rms values and small sine distortion are prerequisite to characterize ADCs, what can also be done with this system.

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